EV317135699

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	00/033
Filing Date Octo	09/6//,4/8
Inventor	»Der 2, 2000
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Attorney's Docket No.	· · · L. VINN
Title: Plasma Etching Methods	MI22-1544

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References - See Attached Form PTO-1449

The Examiner's attention is directed to the references listed on the attached Form PTO-1449, copies of which are attached. No admission is made regarding whether the submitted references are prior art.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated: 6-30-03

D. Brent Kenady

Reg. No. 40,045

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Form PTO-144	9			ATTY, DOCKET NO. Milipatina			SERIAL NO. 09/677.47S			
		LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Bisjeck et al.				
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Ì	AR	Stanley Wolf and Richard Tauber. Silicon Processing for the VLSI Era, Vol. 1, pp 549, 1986.								

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EXAMINER: I	notial if re	forence considi	eted, whether or	r act citation II in	conformance with SIPEF 669; Draw Is	ne through cironon if	not in confor	mance and	not considered.	Înciude